Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/041,761	YOON ET AL.	
Examiner	Art Unit	-
Hung Q. Dang	2621	

SEARCHED			
Class	Subclass	Date	Examiner
386	125.ccls.	12/9/2006	HQD
369	59.25	12/9/2006	HQD
369	47.21	12/9/2006	HQD
369	275.4	12/9/2006	HQD
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		•	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STIC Plus Search	6/2/2006	HQD
Inventors' Names Search	7/25/2006	HQD
USPAT; US-PGPUB; USOCR; EPO: JPO: DERWENT; IBM_TDB (see Search History attached)	08/10/2006- 08/16/2006	HQD
Consulted with Thai Tran	12/08/2006	HQD
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